



STP200NF04L STB200NF04L - STB200NF04L-1

N-CHANNEL 40V - 3 mΩ - 120 A TO-220/D²PAK/I²PAK
STripFET™ II MOSFET

Table 1: General Features

TYPE	V _{DSS}	R _{DS(on)}	I _D
STB200NF04L	40 V	3.5 mΩ	120 A
STP200NF04L	40 V	3.8 mΩ	120 A
STB200NF04L-1	40 V	3.8 mΩ	120 A

- TYPICAL R_{DS(on)} = 3mΩ
- 100% AVALANCHE TESTED
- LOW THERESHOLD DRIVE

DESCRIPTION

This MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strippbased process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less-critical alignment steps therefore a remarkable manufacturing reproducibility. This new improved device has been specifically designed for Automotive applications.

APPLICATIONS

- HIGH CURRENT, HIGH SWITCHING SPEED

Figure 1: Package

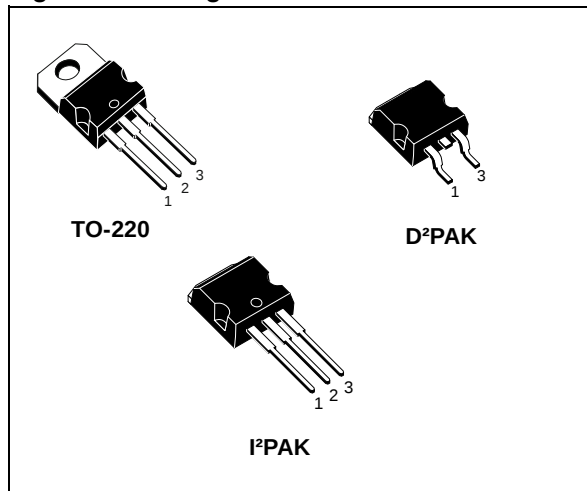


Figure 2: Internal Schematic Diagram

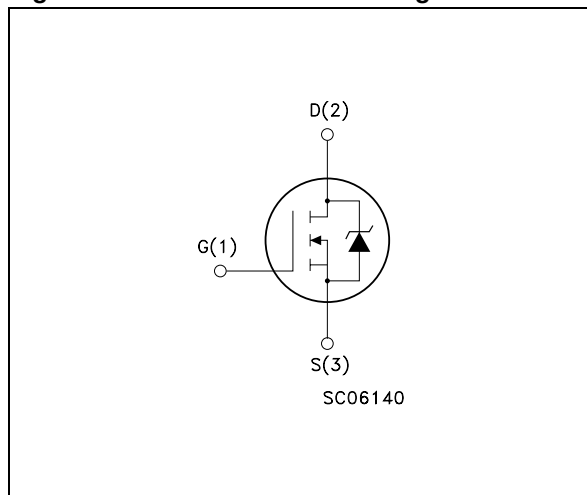


Table 2: Order Codes

PART NUMBER	MARKING	PACKAGE	PACKAGING
STP200NF04L	P200NF04L	TO-220	TUBE
STB200NF04L	B200NF04L	D ² PAK	TAPE & REEL
STB200NF04L-1	B200NF04L	I ² PAK	TUBE

Table 3: Absolute Maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source Voltage ($V_{GS} = 0$)	40	V
V_{GDR}	Drain-gate Voltage ($R_{GS}=20\text{ K}\Omega$)	40	V
V_{GS}	Gate- source Voltage	± 16	V
$I_D (**)$	Drain Current (continuous) at $T_C = 25^\circ\text{C}$	120	A
I_D	Drain Current (continuous) at $T_C = 100^\circ\text{C}$	120	A
$I_{DM} (2)$	Drain Current (pulsed)	480	A
P_{TOT}	Total Dissipation at $T_C = 25^\circ\text{C}$	300	W
	Derating Factor	2	W/ $^\circ\text{C}$
$dv/dt (1)$	Peak Diode Recovery voltage slope	3.6	V/ns
$E_{AS} (3)$	Single Pulse Avalanche Energy	1.4	J
T_{stg}	Storage Temperature	-55 to 175	$^\circ\text{C}$
T_j	Max. Operating Junction Temperature		

(1) $I_{SD} \leq 100\text{ A}$, $di/dt \leq 240\text{ A}/\mu\text{s}$, $V_{DD} \leq 32$, $T_j \leq T_{JMAX}$

(2) Pulse width limited by safe operating area.

(3) Starting $T_j = 25^\circ\text{C}$, $I_{AR} = 50\text{ A}$, $V_{DD} = 30\text{ V}$

(**) Current limited by Package

Table 4: Thermal Data

		TO-220/I ² PAK	D ² PAK	Unit
$R_{thj-case}$	Thermal Resistance Junction-case Max	0.50		$^\circ\text{C}/\text{W}$
$R_{thj-pcb} (*)$	Thermal Resistance Junction-pcb Max		35	$^\circ\text{C}/\text{W}$
R_{thja}	Thermal Resistance Junction-ambient Max	62.5	--	
T_l	Maximum Lead Temperature For Soldering Purpose	300	--	$^\circ\text{C}$

(*)When mounted on 1 inch² FR4 2oZ Cu**ELECTRICAL CHARACTERISTICS** ($T_{CASE} = 25^\circ\text{C}$ UNLESS OTHERWISE SPECIFIED)

Table 5: On/Off

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown Voltage	$I_D = 250\text{ }\mu\text{A}$, $V_{GS} = 0$		40			V
I_{DSS}	Zero Gate Voltage Drain Current ($V_{GS} = 0$)	$V_{DS} = \text{Max Rating}$ $V_D = \text{Max Rating}$, $T_C = 125^\circ\text{C}$				1 10	μA μA
I_{GSS}	Gate-body Leakage Current ($V_{DS} = 0$)	$V_{GS} = \pm 16\text{ V}$				± 100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$		1		4	V
$R_{DS(on)}$	Static Drain-source On Resistance	$V_{GS} = 10\text{ V}$, $I_D = 50\text{ A}$ $V_{GS} = 5\text{ V}$, $I_D = 50\text{ A}$	TO-220 I ² PAK		3.3 3.8	3.8 4.6	m Ω m Ω
		$V_{GS} = 10\text{ V}$, $I_D = 50\text{ A}$ $V_{GS} = 5\text{ V}$, $I_D = 50\text{ A}$	D ² PAK		3.0 3.5	3.5 4.3	m Ω m Ω

ELECTRICAL CHARACTERISTICS (CONTINUED)

Table 6: Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
g_{fs} (4)	Forward Transconductance	$V_{DS} = 15\text{ V}$, $I_D = 20\text{ A}$		60		S
C_{iss} C_{oss} C_{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GS} = 0$		6400 1300 190		pF pF pF
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time	$V_{DD} = 20\text{ V}$, $I_D = 50\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 4.5\text{ V}$ (see Figure 16)		37 270 90 80		ns ns ns ns
$t_{f(voff)}$ t_f t_c	Turn-off Delay Time Fall Time Cross-over Time	$V_{clamp} = 32\text{ V}$, $I_D = 100\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 4.5\text{ V}$ (see Figure 17)		85 125 160		ns ns ns
Q_g Q_{gs} Q_{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 32\text{ V}$, $I_D = 100\text{ A}$, $V_{GS} = 4.5\text{ V}$ (see Figure 19)		72 20 28.5	90	nC nC nC

Table 7: Source Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain Current				100	A
I_{SDM} (1)	Source-drain Current (pulsed)				400	A
V_{SD} (4)	Forward On Voltage	$I_{SD} = 160\text{ A}$, $V_{GS} = 0$			1.3	V
t_{rr} Q_{rr} I_{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 100\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $V_{DD} = 20\text{ V}$, $T_j = 150^\circ\text{C}$ (see Figure 16)		88 240 5.5		ns nC A

(1) Pulse width limited by safe operating area

(4). Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %.

Figure 3: Safe Operating Area

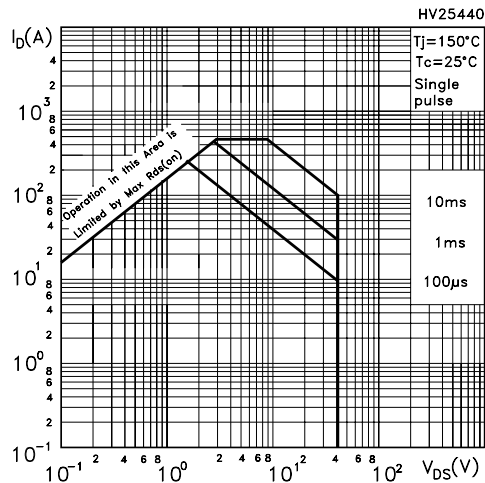


Figure 4: Output Characteristics

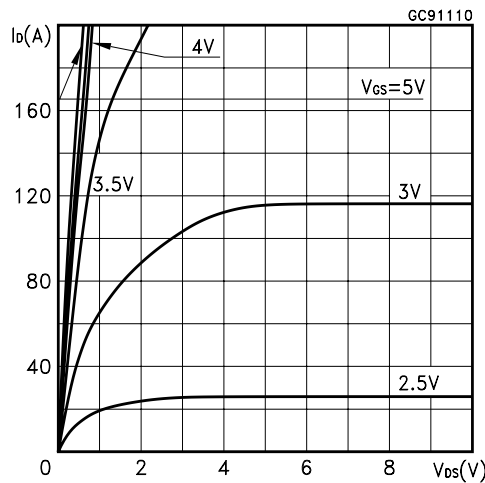


Figure 5: Transconductance

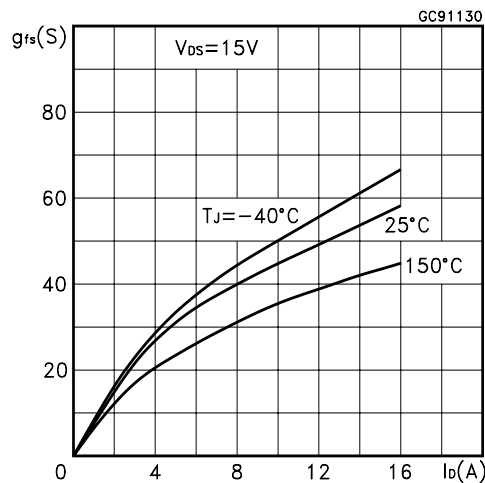


Figure 6: Thermal Impedance

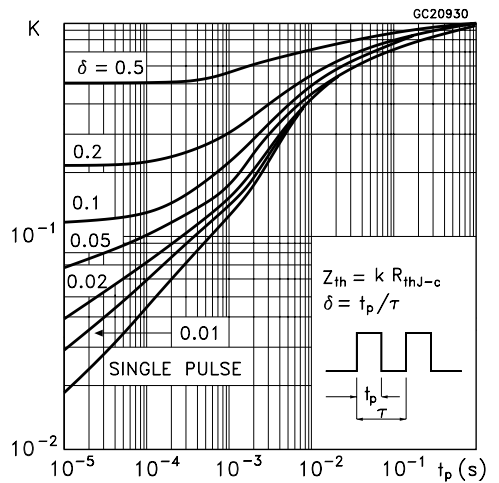


Figure 7: Transfer Characteristics

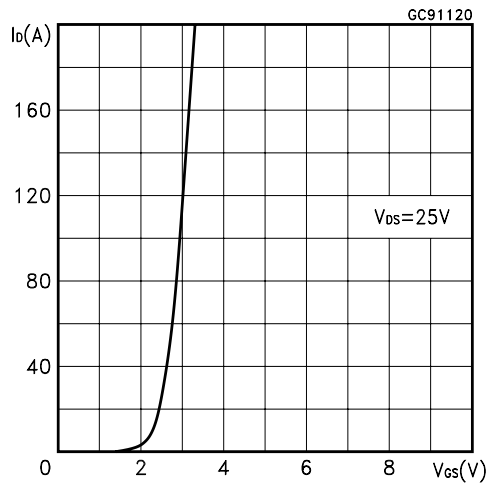


Figure 8: Static Drain-source On Resistance

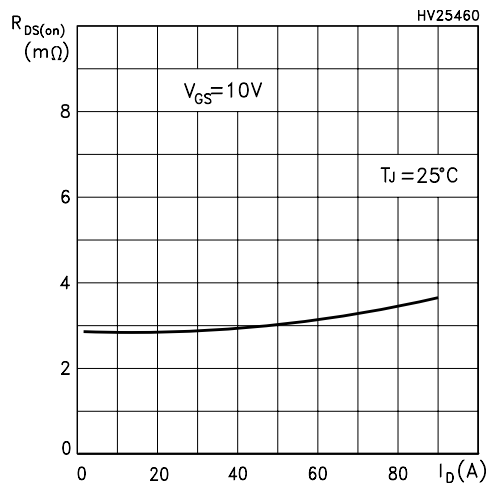


Figure 9: Gate Charge vs Gate-source Voltage

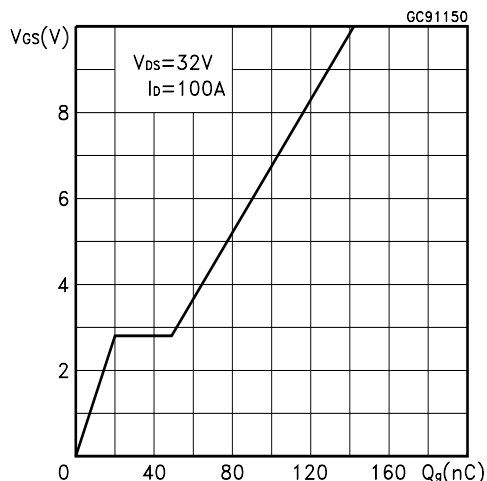


Figure 10: Normalized Gate Threshold Voltage vs Temperature

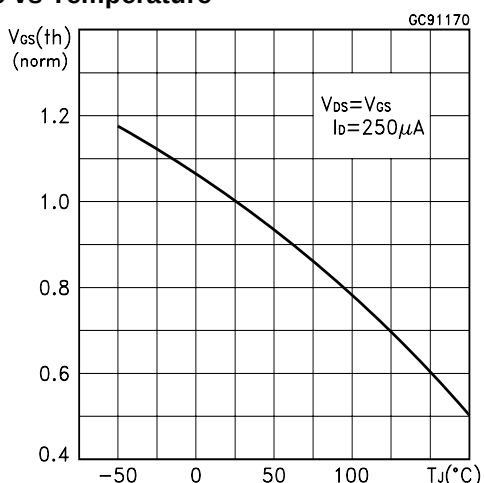


Figure 11: Source-Drain Diode Forward Characteristics

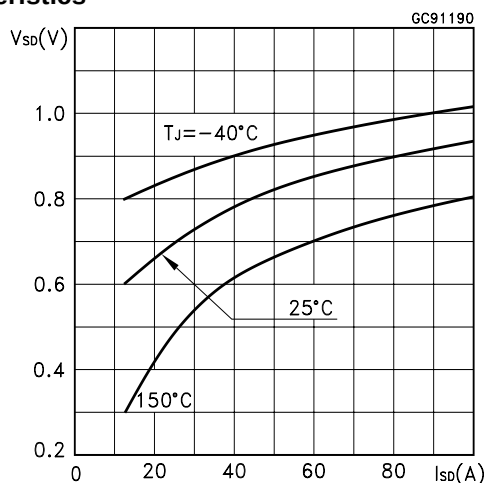


Figure 12: Capacitance Variations

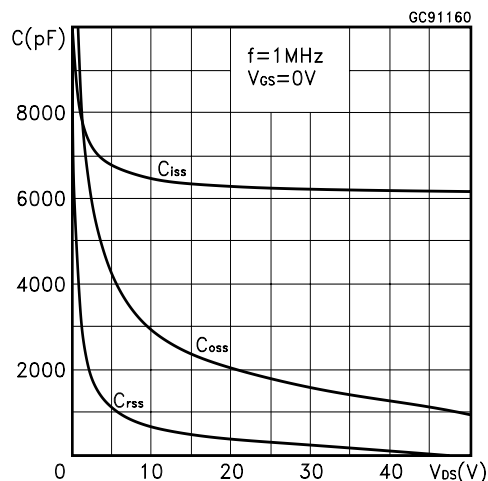


Figure 13: Normalized On Resistance vs Temperature

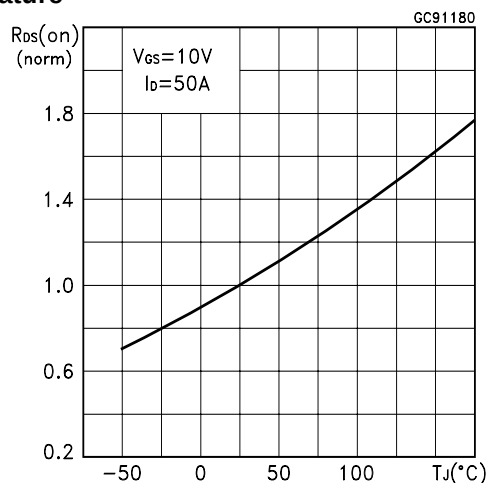


Figure 14: Normalized Breakdown Voltage vs Temperature

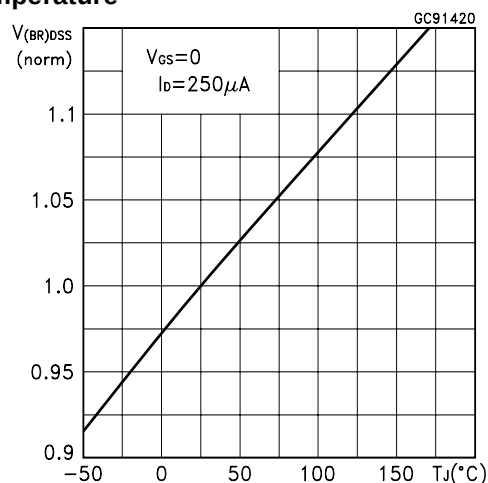


Figure 15: Unclamped Inductive Load Test Circuit

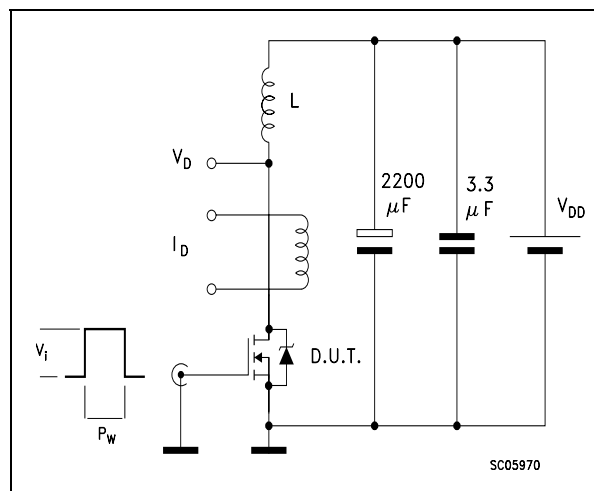


Figure 16: Switching Times Test Circuit For Resistive Load

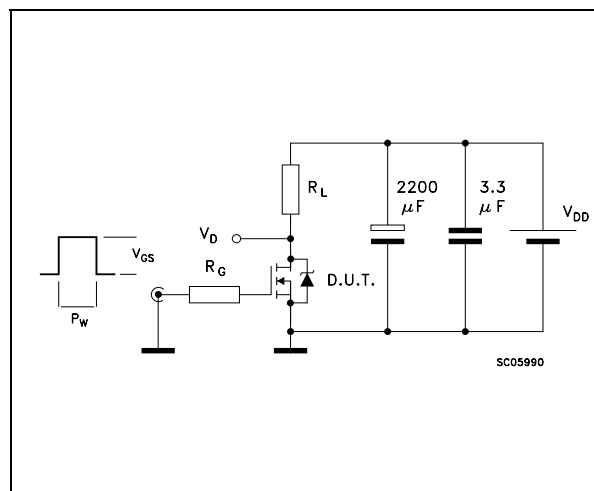


Figure 17: Test Circuit For Inductive Load Switching and Diode Recovery Times

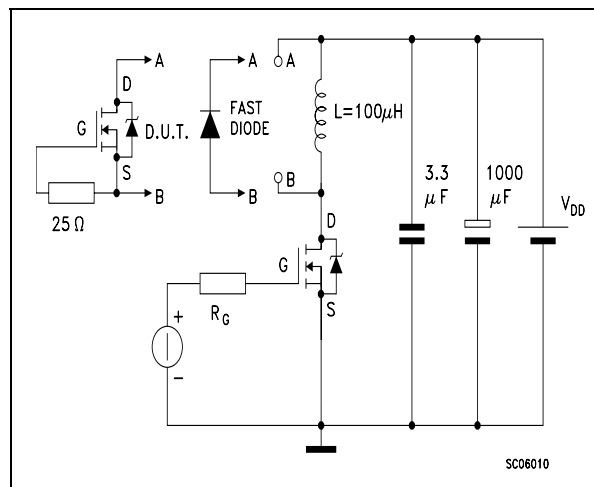


Figure 18: Unclamped Inductive Waferform

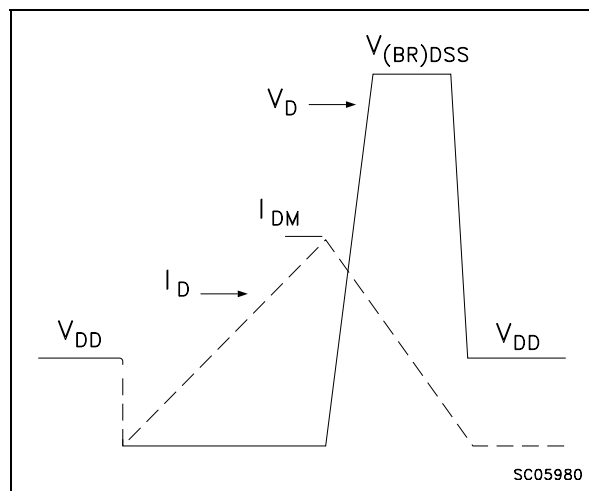
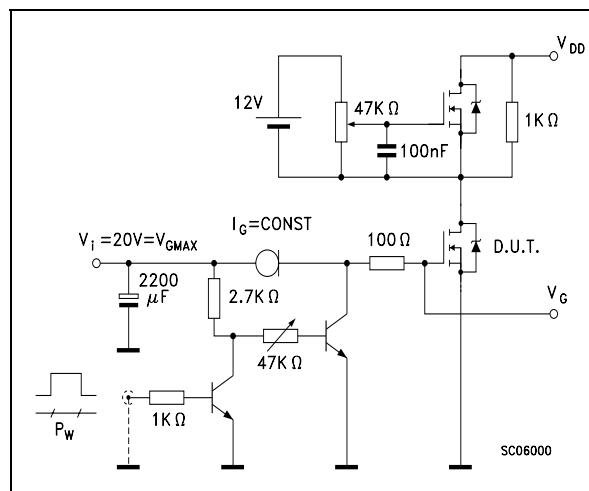
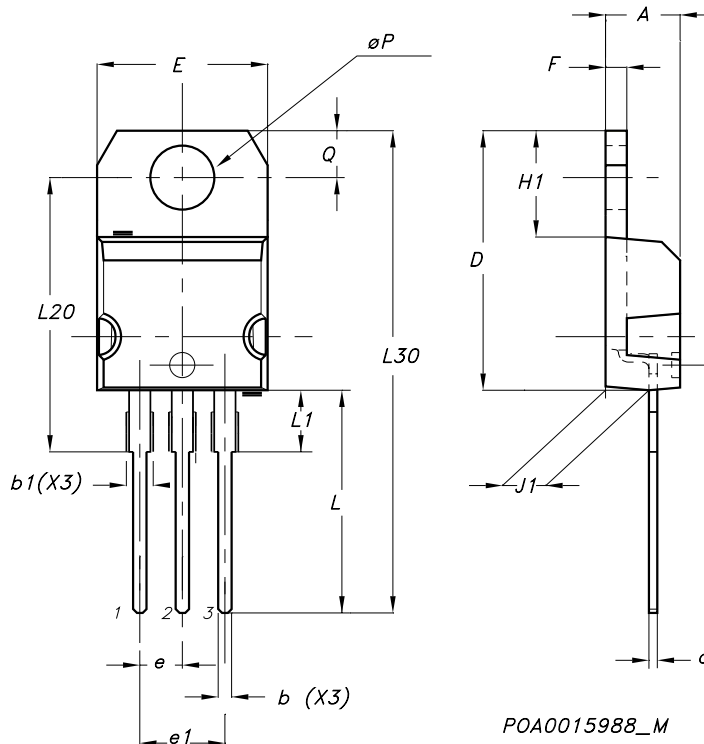


Figure 19: Gate Charge Test Circuit



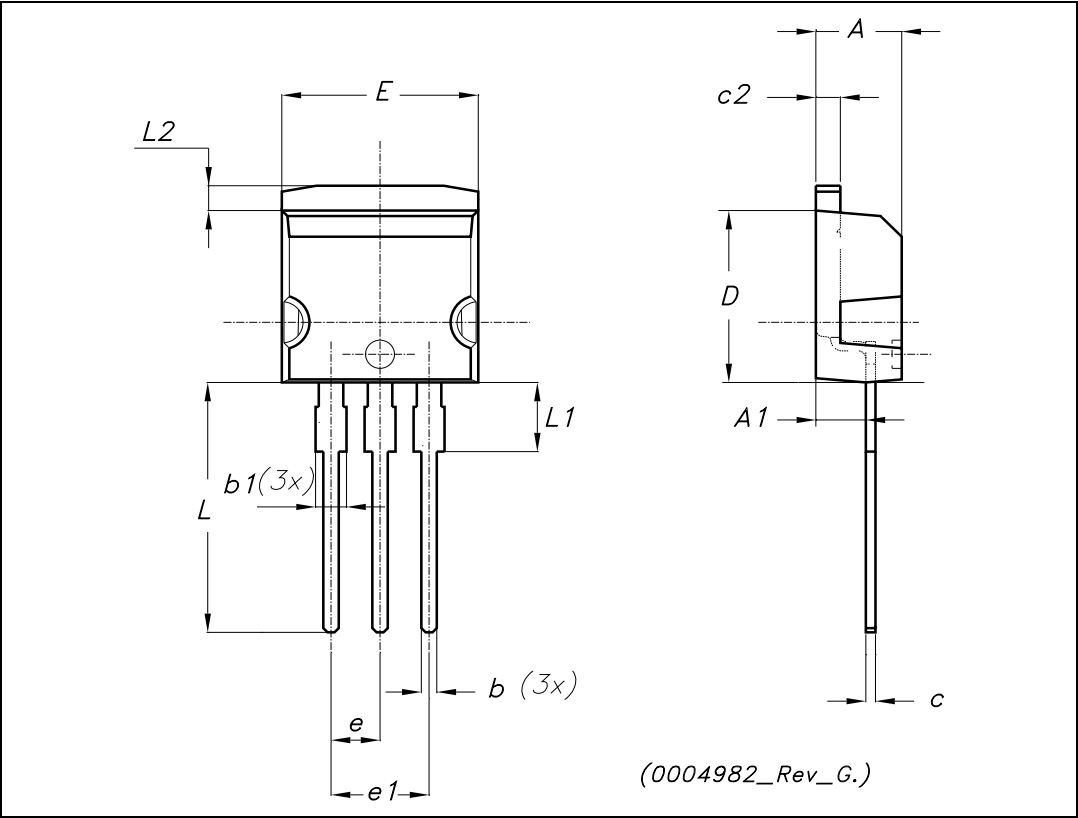
TO-220 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
c	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



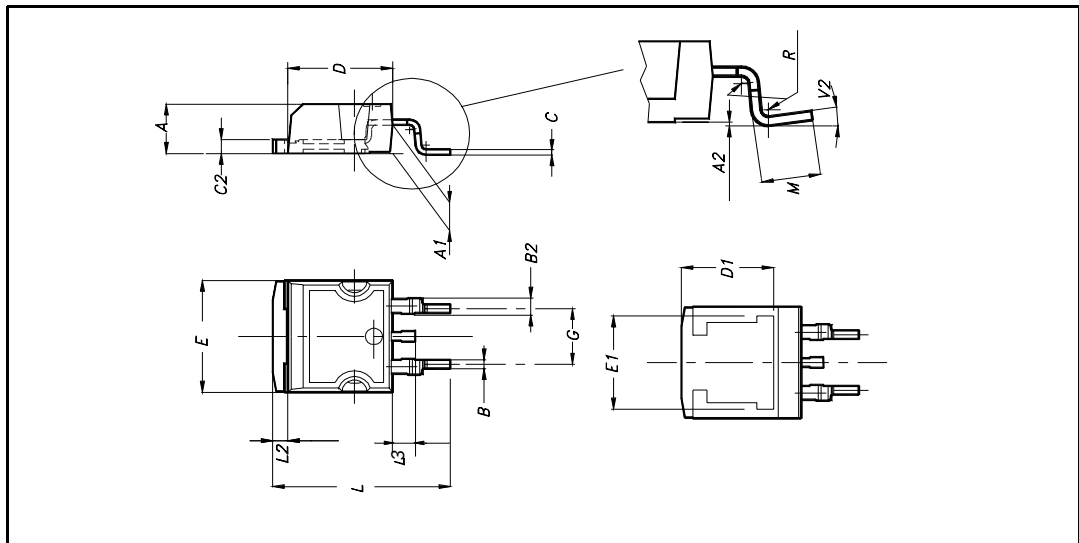
TO-262 (I²PAK) MECHANICAL DATA

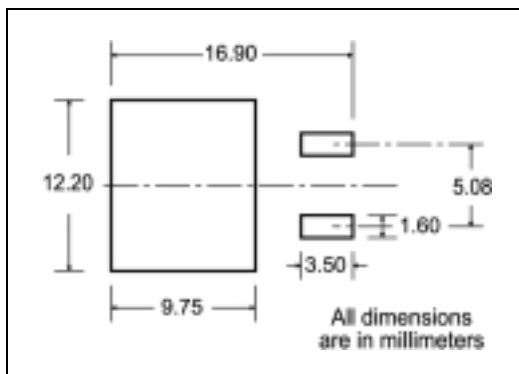
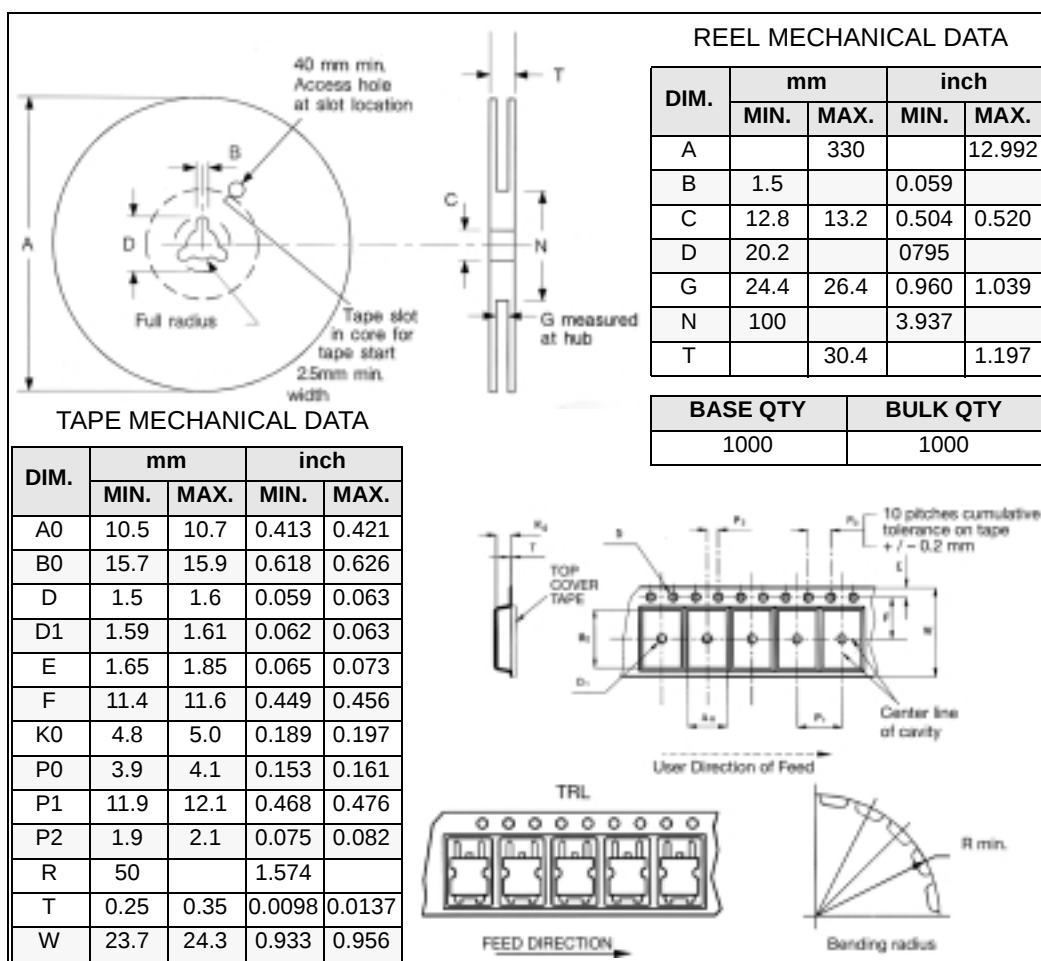
DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.368
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
E	10		10.40	0.393		0.410
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L2	1.27		1.40	0.050		0.055



D²PAK MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
B	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
C	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
M	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0°		4°			



D²PAK FOOTPRINT**TAPE AND REEL SHIPMENT**

* on sales type

Table 8: Revision History

Date	Revision	Description of Changes
11/Apr/2005	1	First Release.

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